

IN THE CLAIMS

1. (Canceled)

2. (Canceled)

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14. (Canceled)

15. (Currently amended) A system for converting an input voltage VIN to a digital

output, comprising: K linear flash-type analog-to-digital (A/D) converter apparatuses Z_1, Z_2, \dots, Z_K respectively characterized by reference voltage step sizes $\Delta V_1, \Delta V_2, \dots, \Delta V_K$ and respectively adapted to convert V_{IN} into multibit strings S_1, S_2, \dots, S_K , wherein $\Delta V_1 < \Delta V_2 < \dots < \Delta V_K$, and wherein K is greater than or equal to 2; and encoder means for combining applying a scale factor to at least a selected one of S_1, S_2, \dots , and S_K to generate the digital output, wherein the digital output has a sufficient number of bits to preserve the accuracy that is contained within S_1, S_2, \dots , and S_K .

16. (Previously presented) The system of claim 15, wherein S_1, S_2, \dots , and S_K each have a same number of bits.

17. (Previously presented) The system of claim 15, wherein S_1, S_2, \dots , and S_K do not each have a same number of bits.

18. (Previously presented) The system of claim 15, wherein for $k=1, 2, \dots, K$ the A/D converter apparatus Z_k comprises an arithmetic unit A_k in series with an A/D converter B_k , wherein the A/D converters have a same working voltage range, wherein V_{IN} is within the working voltage range, wherein the working voltage range comprises K contiguous voltage subranges denoted as $\delta V_1, \delta V_2, \dots, \delta V_K$ in order of lower to higher voltages, wherein for $k=1, 2, \dots, K$ the arithmetic unit A_k is adapted to change V_{IN} into a new input voltage $V_{IN,k}$ in accordance with a transformation of δV_k into the working voltage range and A/D converter B_k is adapted to transform $V_{IN,k}$ into the multibit string S_k .

19. (Currently amended) The system of claim 18, wherein $\delta V_1, \delta V_2, \dots, \delta V_K$ have values such the relative-error of the digital output relative to V_{IN} is a piecewise continuous function of V_{IN} within the working voltage range, said piecewise continuous function of V_{IN} , the piecewise continuous function having K pieces, wherein the relative error within each said piece of the K pieces is a monotonically decreasing function of V_{IN} , and wherein each piece of the K pieces has about a same maximum relative error.

20. (Previously presented) The system of claim 15, wherein $K=2$, wherein the A/D converter apparatuses $Z1$ and $Z2$ comprise A/D converters $B1$ and $B2$ having working voltage ranges $\delta1$ and $\delta2$, respectively, such that $\delta2$ is a subset of $\delta1$ and $\delta2/\delta1$ is an integer subject to $\delta2/\delta1 > 1$, wherein $B1$ and $B2$ are respectively adapted to convert VIN to $S1$ and $S2$, and wherein the encoder means is adapted to generate the digital output as $S2$ if $S2$ is not within the voltage range $\delta1$ else the encoder means is adapted to generate the digital output as $S1$ multiplied by $\delta2/\delta1$.

21. (Previously presented) The system of claim 20, wherein $\delta2/\delta1=2^J$, and wherein J is a positive integer.

22. (Currently amended) A method for converting an input voltage VIN to a digital output, comprising: providing K linear flash-type analog-to-digital (A/D) converter apparatuses $Z1, Z2, \dots, ZK$ respectively characterized by reference voltage step sizes $\Delta V1, \Delta V2, \dots, \Delta VK$, wherein $\Delta V1 < \Delta V2 < \dots < \Delta VK$, and wherein K is greater than or equal to 2; converting VIN , by converter apparatuses $Z1, Z2, \dots, ZK$, into multibit strings $S1, S2, \dots, SK$, respectively; and combining $S1, S2, \dots, SK$ to generate the digital output, wherein the digital output has a sufficient number of bits to preserve the accuracy that is contained within $S1, S2, \dots, SK$.

23. (Previously presented) The system of claim 22, wherein $S1, S2, \dots, SK$ each have a same number of bits.

24. (Previously presented) The method of claim 22, wherein $S1, S2, \dots, SK$ do not each have a same number of bits.

25. (Previously presented) The method of claim 22, wherein for $k=1, 2, \dots, K$ the A/D converter apparatus Zk comprises an arithmetic unit Ak in series with an A/D converter Bk , wherein the A/D converters have a same working voltage range, wherein VIN is within the working voltage range, wherein the working voltage range comprises K contiguous voltage subranges denoted as $\delta V1, \delta V2, \dots, \delta VK$ in order of lower to higher

voltages, said method further comprising: changing V_{IN} by the arithmetic unit A_k for $k=1, 2, \dots, K$, into a new input voltage $V_{IN,k}$ in accordance with a transformation of δV_k into the working voltage range; and transforming $V_{IN,k}$ by the A/D converter B_k , into the multibit string S_k .

26. (Currently amended) The method of claim 25, wherein $\delta V_1, \delta V_2, \dots, \delta V_K$ have values such the relative error of the digital output relative to V_{IN} is a piecewise continuous function of V_{IN} within the working voltage range, said piecewise continuous function of V_{IN} , the piecewise continuous function having K pieces, wherein each two consecutive pieces of the K pieces are discontinuously joined together, wherein the relative error within each said piece of the K pieces is a monotonically decreasing function of V_{IN} , and wherein each piece of the K pieces has about a same maximum relative error.

27. (Previously presented) The method of claim 22, wherein $K=2$, wherein the A/D converter apparatuses Z_1 and Z_2 comprise A/D converters B_1 and B_2 having working voltage ranges Δ_1 and Δ_2 , respectively, such that δ_2 is a subset of δ_1 and δ_2/δ_1 is an integer subject to $\delta_2/\delta_1 > 1$, wherein B_1 and B_2 are respectively adapted to convert V_{IN} to S_1 and S_2 , and wherein said combining includes generating the digital output as essentially S_2 if S_2 is not within the voltage range δ_1 else said combining includes generating the digital output essentially as S_1 multiplied by δ_2/δ_1 .

28. (Previously presented) The method of claim 27, wherein $\delta_2/\delta_1 = 2^J$, and wherein J is a positive integer.